Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/566,682	KOBAYASHI ET AL.	
Examiner	Art Unit	
Eric Elcenko	2617	

SEARCHED					
Class	Subclass	Date	Examiner		
370	334	7/31/2007	EE		
370	339	7/31/2007	EE		
455	101	7/31/2007	EE		
455	103	7/31/2007	EE		
455	522	7/31/2007	EE		
			,		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
Interferen attad		7/31/2007	EE		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
See Attached Papers	7/31/2007	EE		
Consult Duc Nguyen on indepents	7/26/2007	EE		
Consult Steve Nguyen on 370 subject matter in indepence	7/27/2007	EE		